

**Search Notes**

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Applicant(s)/Patent under  
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**SEARCHED**

Class	Subclass	Date	Examiner
Previous Search updated		9/12/05	JN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search, see interference search printout		9/15/2005	JN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR